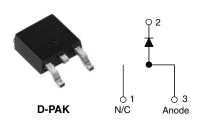
Vishay High Power Products

HEXFRED[®] Ultrafast Soft Recovery Diode, 8 A



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PRODUCT SUMMARY				
V _R	600 V			
V _F at 8 A at 25 °C	1.7 V			
I _{F(AV)}	8 A			
t _{rr} (typical)	18 ns			
T _J (maximum)	150 °C			

FEATURES

- Ultrafast recovery time
- Ultrasoft recovery
- Very low I_{RRM}
- Very low Q_{rr}
- Guaranteed avalanche
- Specified at operating conditions
- Lead (Pb)-free
- Designed and qualified for Q101 level

BENEFITS

- Reduced RFI and EMI
- · Reduced power loss in diode and switching transistor
- Higher frequency operation
- Reduced snubbing
- · Reduced parts count

DESCRIPTION

These diodes are optimized to reduce losses and EMI/RFI in high frequency power conditioning systems. The softness of the recovery eliminates the need for a snubber in most applications. These devices are ideally suited for freewheeling, flyback, power converters, motor drives, and other applications where high speed and reduced switching losses are design requirements.

ABSOLUTE MAXIMUM RATINGS					
PARAMETER	SYMBOL	TEST CONDITIONS	VALUES	UNITS	
Cathode to anode voltage	V _{RRM}		600	V	
Maximum continuous forward current	I _F	T _C = 100 °C	8		
Single pulse forward current	I _{FSM}		60	А	
Peak repetitive forward current	I _{FRM}		24		
Maximum power dissipation	PD	T _C = 100 °C	14	W	
Operating junction and storage temperature range	T _J , T _{Stg}		- 55 to + 150	°C	

ELECTRICAL SPECIFICATIONS (T _J = 25 °C unless otherwise specified)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNITS
Breakdown voltage, blocking voltage	V _{BR} , V _R	I _R = 100 μA		600	-	-	
		I _F = 8 A		-	1.4	1.7	v
Forward voltage V _F	I _F = 16 A	See fig. 1	-	1.7	2.1		
		I _F = 8 A, T _J = 125 °C		-	1.4	1.7	
Maximum reverse		$I_{R} = V_{R} \text{ rated}$ $T_{J} = 125 \text{ °C}, V_{R} = 0.8 \text{ x } V_{R} \text{ rated}$		-	0.3	5.0	
leakage current	IR			-	100	500	μΑ
Junction capacitance	CT	V _R = 200 V	See fig. 3	-	10	25	pF
Series inductance	L _S	Measured lead to lead 5 mm from package body		-	8.0	-	nH

* Pb containing terminations are not RoHS compliant, exemptions may apply





HFA08SD60SPbF

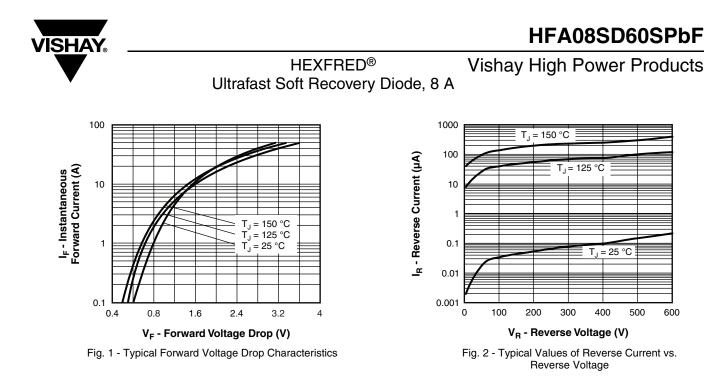


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DYNAMIC RECOVERY CHARACTERISTICS (T _J = 25 °C unless otherwise specified)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNITS
		$I_F = 1.0 \text{ A}, \text{ d}I_F/\text{d}t = 200 \text{ A}/\mu\text{s}, \text{ V}_R = 30 \text{ V}$		-	18	-	
Reverse recovery time	t _{rr}	T _J = 25 °C		-	37	55	ns
	T _J = 125 °C		-	55	90		
Poole rooovoru ourroot	Peak recovery current I _{RRM}	T _J = 25 °C	I _F = 8 A dI _F /dt = 200 A/μs V _R = 200 V	-	3.5	5.0	A
Feak recovery current		T _J = 125 °C		-	4.5	8.0	
		T _J = 25 °C		-	65	138	nC
Reverse recovery charge Q _{rr}	Qrr	T _J = 125 °C		-	124	360	
Rate of fall of recovery current dI _{(rec)M} /dt	dl/dt	T _J = 25 °C		-	240	-	A/µs
	T _J = 125 °C		-	210	-	Ανμs	

THERMAL - MECHANICAL SPECIFICATIONS						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Maximum junction and storage temperature range	T _J , T _{Stg}		- 55	-	150	°C
Lead temperature	T _{lead}		-	-	300	
Thermal resistance, junction to case	R _{thJC}		-	-	3.5	°C/W
Thermal resistance, junction to ambient	R _{thJA}	Typical socket mount	-	-	80	0/00
Maight			-	2.0	-	g
Weight			-	0.07	-	oz.
Marking device		Case style D-PAK		HFA08	SD60S	



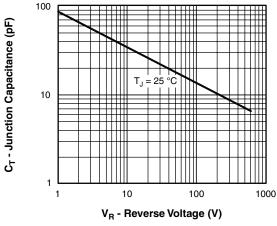


Fig. 3 - Typical Junction Capacitance vs. Reverse Voltage

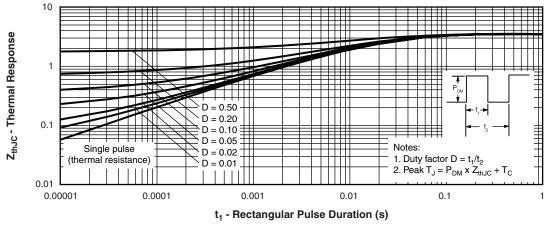


Fig. 4 - Maximum Thermal Impedance Z_{thJC} Characteristics

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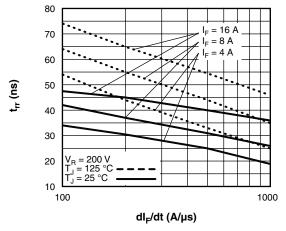
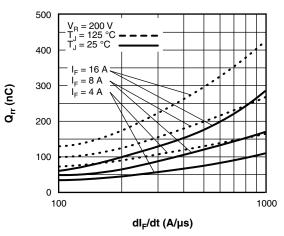


Fig. 5 - Typical Reverse Recovery Time vs. dl_F/dt



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Fig. 7 - Typical Stored Charge vs. dI_F/dt

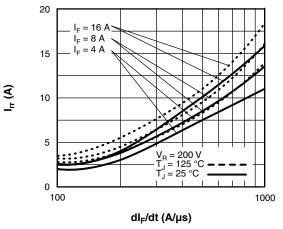


Fig. 6 - Typical Recovery Current vs. dI_F/dt

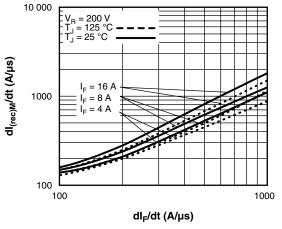


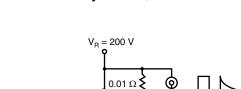
Fig. 8 - Typical dI_{(rec)M}/dt vs. dI_F/dt





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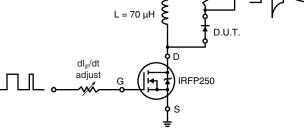
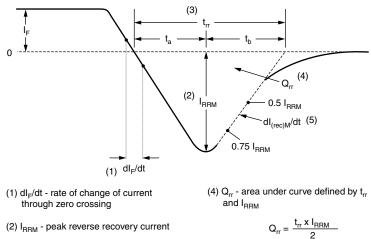


Fig. 9 - Reverse Recovery Parameter Test Circuit



(3) t_{rr} - reverse recovery time measured from zero crossing point of negative going I_F to point where a line passing through 0.75 I_{RRM} and 0.50 I_{RRM} extrapolated to zero current. (5) dl_{(rec)M}/dt - peak rate of change of current during t_b portion of t_{rr}

Fig. 10 - Reverse Recovery Waveform and Definitions

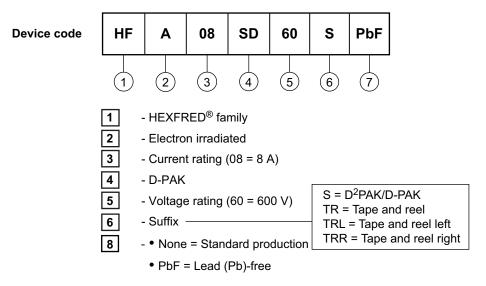
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ORDERING INFORMATION TABLE



LINKS TO RELATED DOCUMENTS				
Dimensions	http://www.vishay.com/doc?95016			
Part marking information	http://www.vishay.com/doc?95059			
Packaging information	http://www.vishay.com/doc?95033			



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